TOSHIBA Transistor Silicon PNP Epitaxial Type (PCT Process)

2SA1431

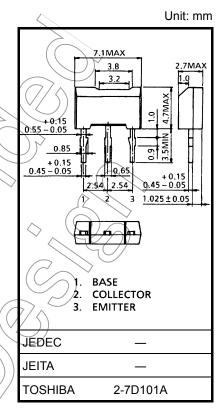
Strobe Flash Applications

Medium Power Amplifier Applications

- $\bullet \quad \mbox{High DC}$ current gain and excellent hFE linearity
 - $h_{FE(1)} = 100 \text{ to } 320 \text{ (V}_{CE} = -2 \text{ V, I}_{C} = -0.5 \text{ A)}$
 - $h_{FE(2)} = 70 \text{ (min) } (V_{CE} = -2 \text{ V}, I_{C} = -4 \text{ A})$
- Low saturation voltage: VCE (sat) = -1.0 V (max) (IC = -4 A, IB = -0.1 A)

Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Collector-base voltage		V_{CBO}	-35	V	
Collector-emitter voltage		V _{CEO}	-20	V V	
Emitter-base voltage		V _{EBO}	-8	V	
Collector current	DC	lc _	-5		
	Pulsed (Note 1)	I _{CP} -8		A	
Base current		-0.5		Α	
Collector power dissipation		(Pc	1000	mW	
Junction temperature		T	Tj 150 (
Storage temperature range		T _{stg}	-55 to 150)°C	



Weight: 0.2 g (typ.)

- Note 1: Pulse width \neq 10 ms (max), duty cycle = 30% (max)
- Note 2: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

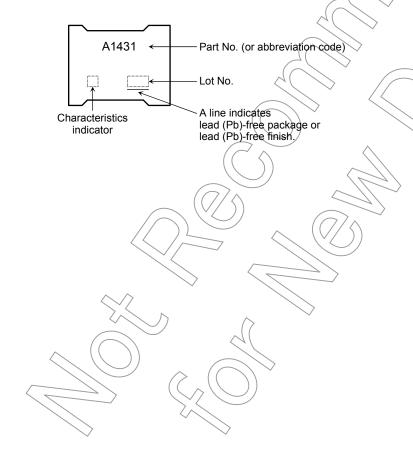
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Electrical Characteristics (Ta = 25°C)

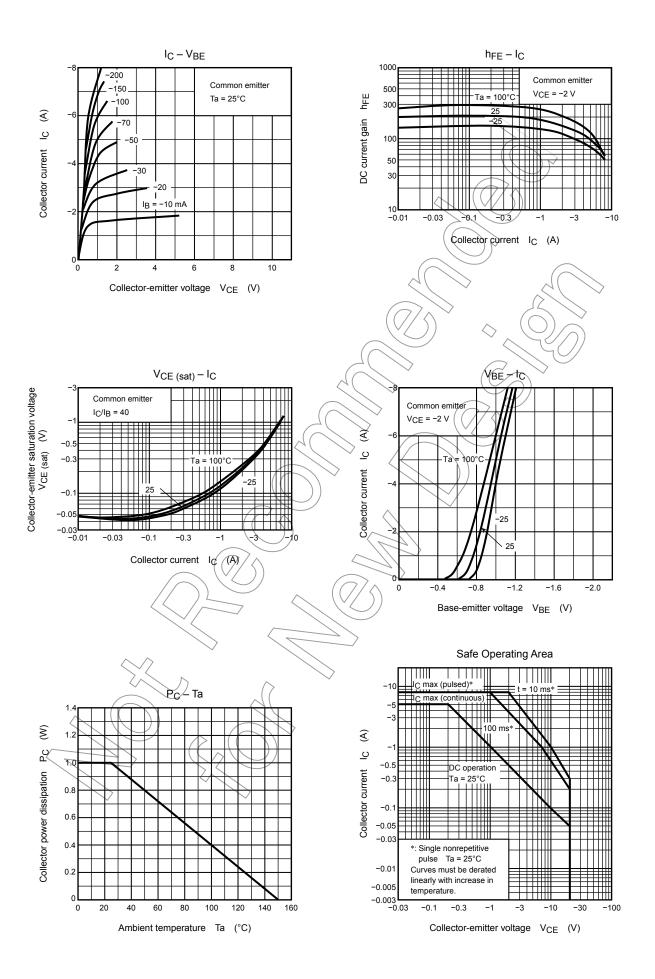
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I _{CBO}	$V_{CB} = -35 \text{ V}, I_{E} = 0$	_	_	-100	nA
Emitter cut-off current	I _{EBO}	V _{EB} = -8 V, I _C = 0	_	_	-100	nA
Collector-emitter breakdown voltage	V (BR) CEO	I _C = -10 mA, I _B = 0	-20	_	_	V
Emitter-base breakdown voltage	V (BR) EBO	$I_E = -1 \text{ mA}, I_C = 0$	-8	_	_	V
DC current gain	h _{FE (1)} (Note 3)	V _{CE} = -2 V, I _C = -0.5 A	100) _	320	
	h _{FE (2)}	V _{CE} = -2 V, I _C = -4 A	79	_	_	
Collector-emitter saturation voltage	V _{CE} (sat)	I _C = -4 A, I _B = -0.1 A	_	_	-1.0	V
Base-emitter voltage	V _{BE}	V _{CE} = -2 V, I _C = -4 A	_	_	-1.5	V
Transition frequency	f _T	V _{CE} = -2 V, I _C = -0.5 A	_	170	_	MHz
Collector output capacitance	C _{ob}	V _{CB} = -10 V, I _E = 0, f = 1 MHz		62	\rightarrow	pF

Note 3: h_{FE} (1) classification O: 100 to 200, Y: 160 to 320

Marking



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